

Search Notes

Application/Control No.

10/780,776

Examiner

Luan K. Bui

Applicant(s)/Patent under
Reexamination

DANIEL, JEAN-YVES

Art Unit

3728

SEARCHED

Class	Subclass	Date	Examiner
Updated	previous	2/1/2006	LKB
search			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR